

Notice of References Cited	Application/Control No. 09/740,113	Applicant(s)/Patent Under Reexamination SEITZ ET AL.	
	Examiner Thanh Y. Tran	Art Unit 2827	Page 1 of 1

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*	B	US-6,288,422	09-2001	Mandelman et al.	257/301
*	C	US-6,391,705	05-2002	Hsiao et al.	438/243
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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